

## CLAIMS

- 1 1. Method for determining an offset-reduced Hall voltage ( $U_h$ ), and/or an offset voltage  
2 ( $U_{h,offset}$ ) of a Hall sensor (1), comprising:  
3 applying a Hall sensor current ( $I$ ) at a first and second taps ( $a_1$ ,  $a_2$ ,  $a_3$ ) of the Hall  
4 sensor (1), and determining a first Hall voltage ( $U_{h1}$ ) at the third and fourth taps ( $a_3$ ,  $a_4$ )  
5 displaced from the first and second taps ( $a_1$ ,  $a_2$ ,  $a_5$ ),  
6 applying a second Hall sensor current modified relative to the first, and determining a  
7 second Hall voltage ( $U_{h2}$ ), and  
8 determining the Hall voltage ( $U_h$ ) and/or Hall voltage offset ( $U_{h,offset}$ ) from the first  
9 and second Hall voltages determined ( $U_{h1}$ ,  $U_{h2}$ ), characterized in that  
10 the application of the second Hall current  $I$  is effected at taps that are spatially  
11 displaced from the first and/or second taps ( $a_3$ ,  $a_4$ ).
- 1 2. Method according to claim 1, wherein the second Hall voltage ( $U_{h2}$ ) is effected at  
2 taps ( $a_1$ ,  $a_2$ ) that are spatially displaced from the taps ( $a_3$ ,  $a_4$ ) for determining the first Hall  
3 voltage ( $U_{h1}$ ).
- 1 3. Method according to claim 2, wherein in order to determine the second Hall voltage  
2 ( $U_{h2}$ ) this voltage is tapped at taps ( $a_1$ ,  $a_2$ ) for the application of the first Hall current ( $I$ ), and  
3 the second Hall sensor current ( $I$ ) is applied at taps for tapping the first Hall voltage ( $U_{h1}$ ).
- 1 4. Method according to claim 3, wherein the compensated Hall voltage ( $U_h$ ) is  
2 determined by the addition of the first and second Hall voltages ( $U_{h1}$ ,  $U_{h2}$ ).

- 1 5. Method according to claim 1, wherein the Hall voltage offset ( $U_{h,offset}$ ) is  
2 determined by the subtraction of the first and second Hall voltages ( $U_{h1}$ ,  $U_{h2}$ ).
- 1 6. Method according to claim 1, wherein a reduced Hall voltage ( $U_h$ ) is determined with  
2 a first linear arrangement of first through fifth taps ( $a_1 - a_5$ ) to determine an angular  
3 component of the magnetic field  $B$ , and an additional Hall voltage is determined with a  
4 second linear arrangement of taps ( $a_1$ ,  $a_2^* - a_5^*$ ) in an arrangement which is nonlinear and  
5 oriented at an angle relative to the first arrangement.
- 1 7. Method according to claim 1, wherein an interpolation of intermediate results is  
2 performed using taps arranged in a spatially nonlinear configuration.
- 1 8. An offset-reduced Hall sensor (1), comprising:  
2 taps ( $a_1 - a_5$ ) to tap or apply voltages and/or currents, and  
3 a control device (C) to apply a first Hall sensor current (1) through a first central tap  
4 ( $a_1$ ), and two second taps ( $a_2$ ,  $a_5$ ) displaced relative to the first tap, and to determine a first  
5 Hall voltage ( $U_1$ ) on both sides of the first tap ( $a_1$ ) between a third and fourth tap ( $a_1$ ,  $a_4$ )  
6 that are located between the first tap ( $a_1$ ) and fourth taps ( $a_2$ ,  $a_5$ ) - the arrangement  
7 comprising a first measurement system, characterized in that  
8 the control device (C) has a switching device to apply a second Hall sensor current or  
9 the Hall sensor current ( $I$ ) at taps that are spatially displaced relative to the first, second, and  
10 additional second taps ( $a_1$ ,  $a_2$ ,  $a_5$ ), and to tap a second Hall voltage ( $U_{h2}$ ) at taps ( $a_1$ ,  $a_2$ ) that  
11 are spatially displaced relative to the third and fourth taps ( $a_3$ ,  $a_4$ ) - the arrangement  
12 comprising a second measurement system.

- 1 9. The hall sensor of claim 8, wherein the control device (C) has a switching device (C)  
2 to apply a second Hall sensor current (I) at the third and fourth taps (a3, a4), and to tap a  
3 second Hall voltage (Uh2) between the first and second or additional second taps (a1, a2, a5)  
4 - the arrangement comprising a second measurement system.
- 1 10. The hall sensor of claim 9, wherein the second and the additional second taps (a2, a5)  
2 are connected at a common terminal to apply the Hall sensor current (I), or to tap the Hall  
3 voltage (Uh2).
- 1 11. The hall sensor of claim 10, comprising a memory device (M) to store the first and/or  
2 second Hall voltage (Uh1, Uh2), and an analyzer (C) to determine an offset-compensated  
3 Hall voltage (Uh) from the Hall voltages (Uh1, Uh2) tapped under the conditions provided by  
4 the first and second different measurement systems.
- 1 12. The hall sensor of claim 11, wherein the taps (a1 - a5) are located in a plane spanned  
2 by the flow direction of the Hall sensor current (I) and of the magnetic field (B) to be  
3 detected, or in a plane parallel thereto in the manner of a vertical Hall sensor.
- 1 13. The hall sensor of claim 12, wherein  
2 a first measurement group having mutually linear first through fourth taps (a1 - a5)  
3 forms a first measurement system and a second measurement system, and  
4 a second measurement group forms a first and a second measurement system of the  
5 first through fourth taps (a1, a3\* - a5\*) that are arranged linearly relative to each other and  
6 pivoted by an angle ( $\alpha$ ) relative to the first measurement group (a1 - a5) within the plane.

1 14. The hall sensor of claim 12, wherein  
2 a plurality of second taps (a2, a2\*, a2', a5, a5\*, a5') displaced from the first tap (a1) are  
3 distributed around a circular first track (d1), and  
4 a plurality of third taps (a3, a3\*) and fourth taps (a4, a4\*) displaced from the first tap  
5 (a1) are arranged on a second circular track (d2), the first track (d1) being further removed  
6 from the first tap (a1) than the second track (d2).

1 15. The hall sensor of claim 14, wherein  
2 the number of taps (a2, a2\*, a2', a5, a5\*, a5') on the first track (d1) is greater than the  
3 number of taps (a3, a3\*, a4, a4\*) on the second track (d2), and  
4 an analyzer (C) is provided to determine intermediate positions for additional  
5 positions on the second track (d2) without an existing tap (a3').